

## N-Channel 40-V (D-S), 175 °C MOSFET

PRODUCT SUMMARY			
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (Ω)	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)
40	0.0065 at V <sub>GS</sub> = 10 V	20	53.6 nC
	0.008 at V <sub>GS</sub> = 4.5 V	20	

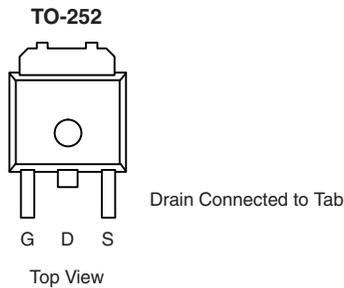
### FEATURES

- TrenchFET<sup>®</sup> Power MOSFET
- 100 % R<sub>g</sub> and UIS Tested

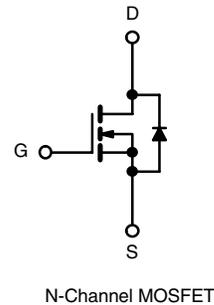

**RoHS**  
COMPLIANT

### APPLICATIONS

- LCD TV Inverter
- Secondary Synchronous Rectification



Ordering Information: SUD50N04-06P-E3 (Lead (Pb)-free)



ABSOLUTE MAXIMUM RATINGS T <sub>A</sub> = 25 °C, unless otherwise noted				
Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V <sub>DS</sub>	40	V	
Gate-Source Voltage	V <sub>GS</sub>	± 16		
Continuous Drain Current (T <sub>J</sub> = 150 °C)	I <sub>D</sub>	T <sub>C</sub> = 25 °C	20 <sup>c</sup>	
		T <sub>C</sub> = 100 °C	20 <sup>c</sup>	
		T <sub>A</sub> = 25 °C	15.9 <sup>b</sup>	
		T <sub>A</sub> = 100 °C	11 <sup>b</sup>	
Pulsed Drain Current	I <sub>DM</sub>	60	A	
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C		20 <sup>c</sup>
		T <sub>A</sub> = 25 °C		2.5 <sup>b</sup>
Single Pulse Avalanche Current	I <sub>AS</sub>	30	mJ	
Avalanche Energy	E <sub>AS</sub>	45		
Maximum Power Dissipation	P <sub>D</sub>	T <sub>C</sub> = 25 °C	79	
		T <sub>C</sub> = 100 °C	39.5	
		T <sub>A</sub> = 25 °C	3.3 <sup>b</sup>	
		T <sub>A</sub> = 100 °C	1.6 <sup>b</sup>	
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 175	°C	

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient <sup>b</sup>	Steady State	R <sub>thJA</sub>	37	4.5	°C/W
Maximum Junction-to-Case	Steady State	R <sub>thJC</sub>	1.5	1.9	

Notes:

- Based on T<sub>C</sub> = 25 °C.
- Surface Mounted on 1" x 1" FR4 board.
- Package limited.

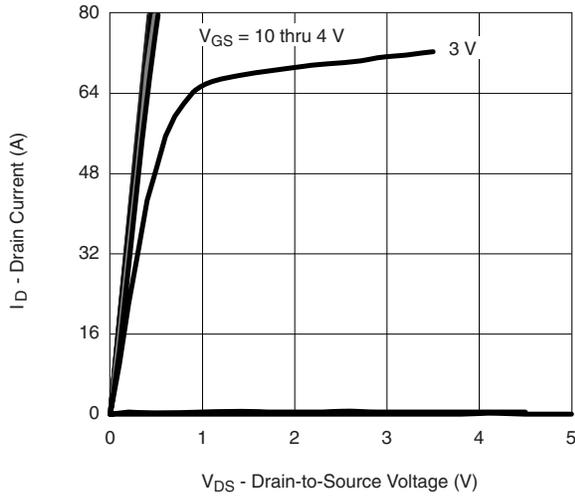
<b>SPECIFICATIONS</b> $T_J = 25\text{ }^\circ\text{C}$ , unless otherwise noted						
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
<b>Static</b>						
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0\text{ V}, I_D = 250\text{ }\mu\text{A}$	40			V
$V_{DS}$ Temperature Coefficient	$\Delta V_{DS}/T_J$	$I_D = 250\text{ }\mu\text{A}$		35		mV/ $^\circ\text{C}$
$V_{GS(th)}$ Temperature Coefficient	$\Delta V_{GS(th)}/T_J$			- 6.0		
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\text{ }\mu\text{A}$	0.8		2.2	V
Gate-Source Leakage	$I_{GSS}$	$V_{DS} = 0\text{ V}, V_{GS} = \pm 16\text{ V}$			$\pm 100$	nA
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 40\text{ V}, V_{GS} = 0\text{ V}$			1	$\mu\text{A}$
		$V_{DS} = 40\text{ V}, V_{GS} = 0\text{ V}, T_J = 100\text{ }^\circ\text{C}$			20	
On-State Drain Current <sup>a</sup>	$I_{D(on)}$	$V_{DS} \geq 5\text{ V}, V_{GS} = 10\text{ V}$	30			A
Drain-Source On-State Resistance <sup>a</sup>	$R_{DS(on)}$	$V_{GS} = 10\text{ V}, I_D = 15\text{ A}$		0.0053	0.0065	$\Omega$
		$V_{GS} = 4.5\text{ V}, I_D = 10\text{ A}$		0.0063	0.008	
Forward Transconductance <sup>a</sup>	$g_{fs}$	$V_{DS} = 15\text{ V}, I_D = 15\text{ A}$		83		S
<b>Dynamic<sup>b</sup></b>						
Input Capacitance	$C_{iss}$	$V_{DS} = 20\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$		5080		pF
Output Capacitance	$C_{oss}$			555		
Reverse Transfer Capacitance	$C_{rss}$			402		
Total Gate Charge	$Q_g$	$V_{DS} = 20\text{ V}, V_{GS} = 10\text{ V}, I_D = 30\text{ A}$		110	165	nC
				53.6	80	
Gate-Source Charge	$Q_{gs}$	$V_{DS} = 20\text{ V}, V_{GS} = 4.5\text{ V}, I_D = 30\text{ A}$		8.8		nC
Gate-Drain Charge	$Q_{gd}$			18.4		
Gate Resistance	$R_g$		$f = 1\text{ MHz}$		1.2	
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = 20\text{ V}, R_L = 0.66\text{ }\Omega$ $I_D \cong 30\text{ A}, V_{GEN} = 4.5\text{ V}, R_g = 1\text{ }\Omega$		24	36	ns
Rise Time	$t_r$			142	215	
Turn-Off Delay Time	$t_{d(off)}$			142	215	
Fall Time	$t_f$			92	140	
Turn-On Delay Time	$t_{d(on)}$	$V_{DD} = 20\text{ V}, R_L = 0.66\text{ }\Omega$ $I_D \cong 30\text{ A}, V_{GEN} = 10\text{ V}, R_g = 1\text{ }\Omega$		8	16	
Rise Time	$t_r$			19	30	
Turn-Off Delay Time	$t_{d(off)}$			50	75	
Fall Time	$t_f$			11	18	
<b>Drain-Source Body Diode Characteristics</b>						
Continuous Source-Drain Diode Current	$I_S$	$T_C = 25\text{ }^\circ\text{C}$			20	A
Pulse Diode Forward Current <sup>a</sup>	$I_{SM}$				50	
Body Diode Voltage	$V_{SD}$	$I_S = 10\text{ A}$		0.76	1.2	V
Body Diode Reverse Recovery Time	$t_{rr}$	$I_F = 20\text{ A}, di/dt = 100\text{ A}/\mu\text{s}, T_J = 25\text{ }^\circ\text{C}$		36	55	ns
Body Diode Reverse Recovery Charge	$Q_{rr}$			40	60	nC
Reverse Recovery Fall Time	$t_a$			20		ns
Reverse Recovery Rise Time	$t_b$			16		

Notes:

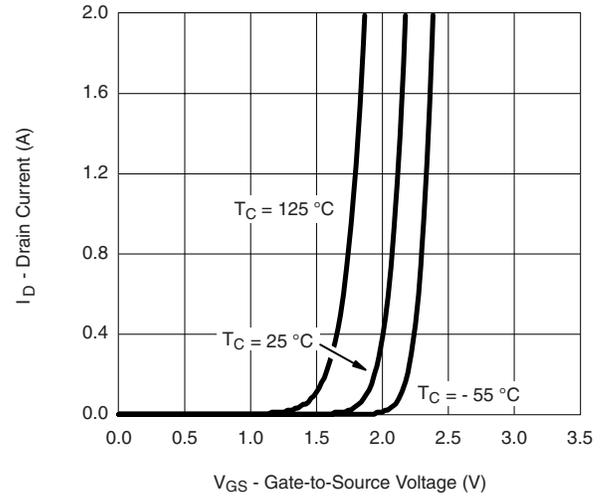
a. Pulse test; pulse width  $\leq 300\text{ }\mu\text{s}$ , duty cycle  $\leq 2\%$ .

b. Guaranteed by design, not subject to production testing.

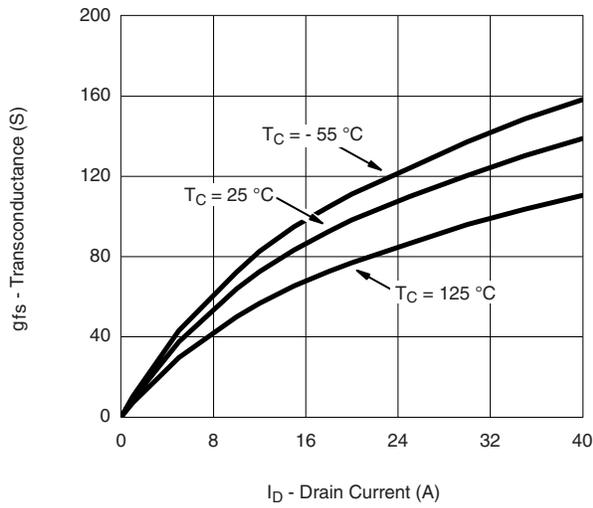
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

**TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted


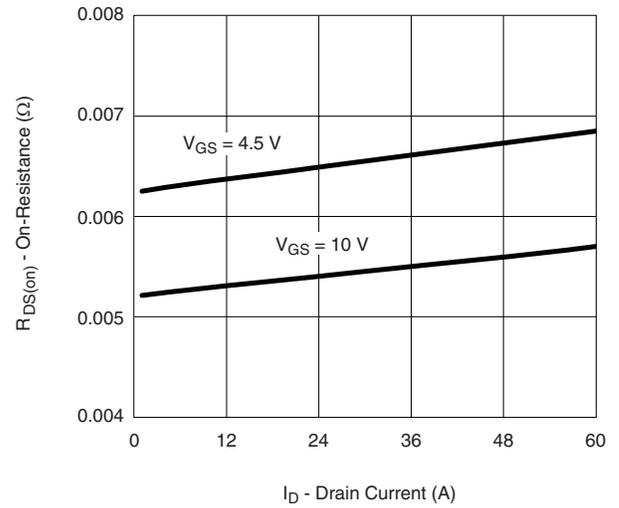
$V_{GS}$  = 10 thru 4 V  
3 V  
**Output Characteristics**



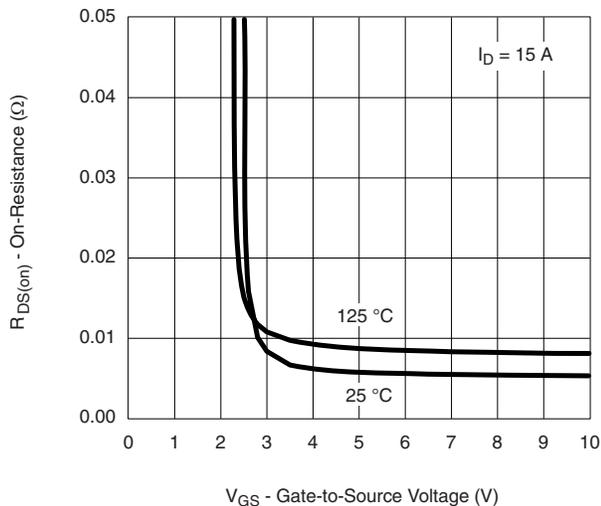
$T_C = 125^\circ\text{C}$   
 $T_C = 25^\circ\text{C}$   
 $T_C = -55^\circ\text{C}$   
**Transfer Characteristics**



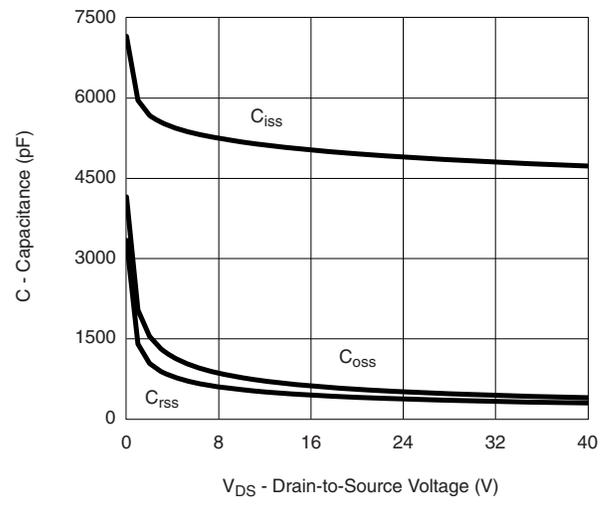
$T_C = -55^\circ\text{C}$   
 $T_C = 25^\circ\text{C}$   
 $T_C = 125^\circ\text{C}$   
**Transconductance**



$V_{GS} = 4.5\text{ V}$   
 $V_{GS} = 10\text{ V}$   
**On-Resistance vs. Drain Current**

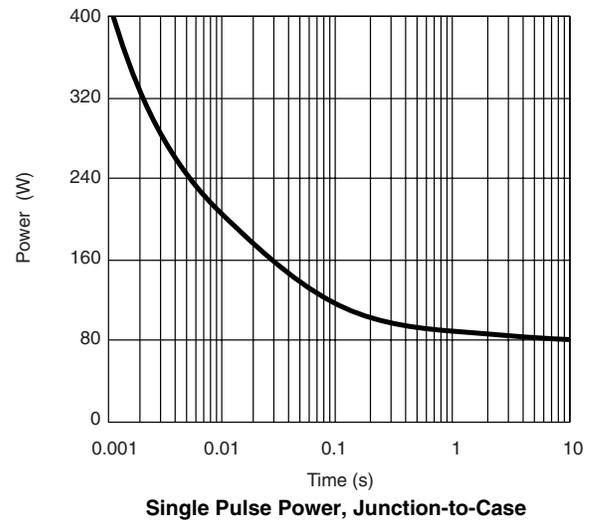
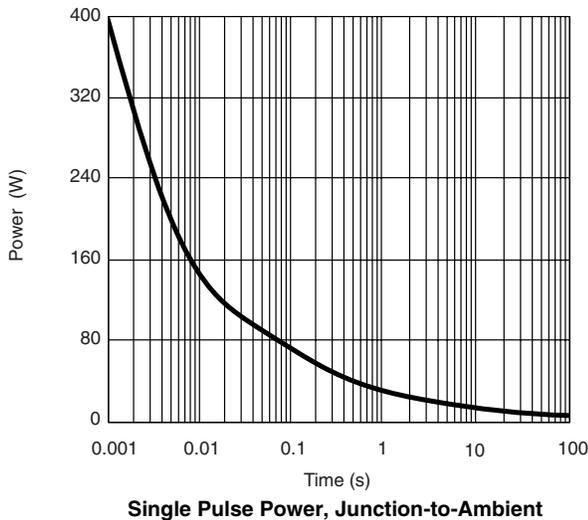
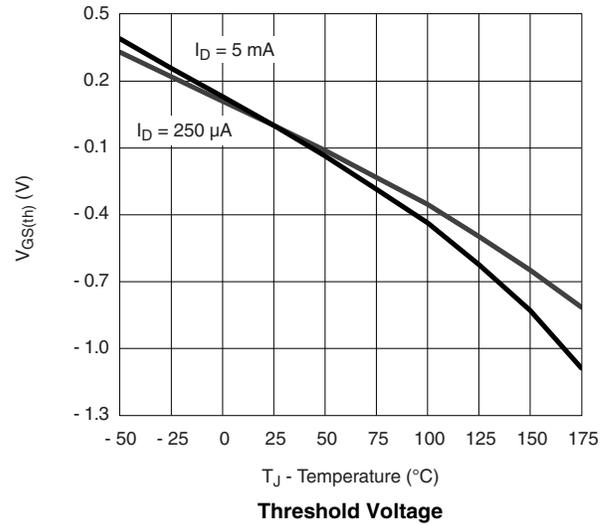
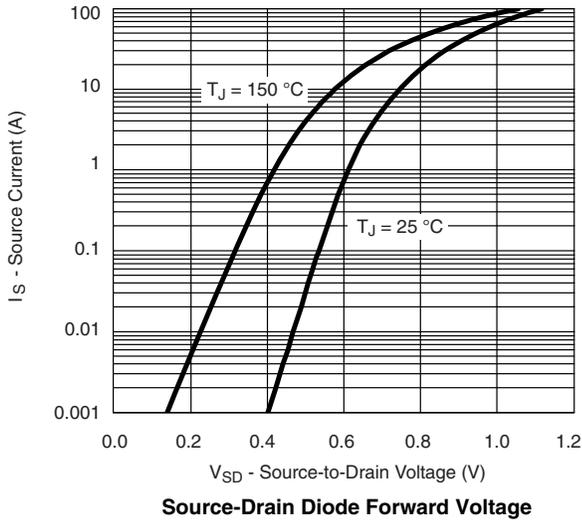
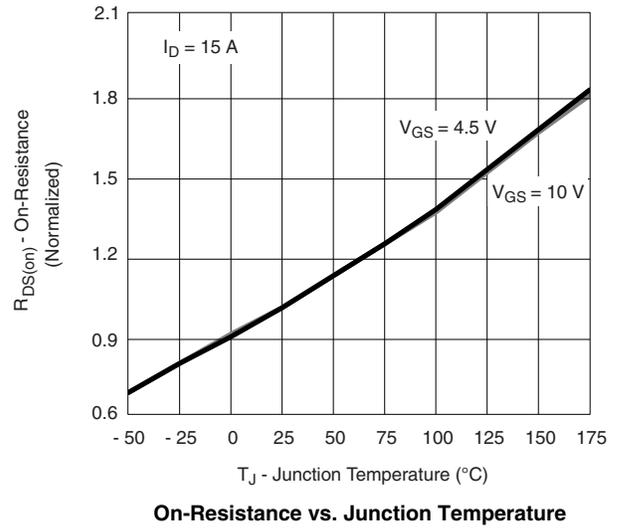
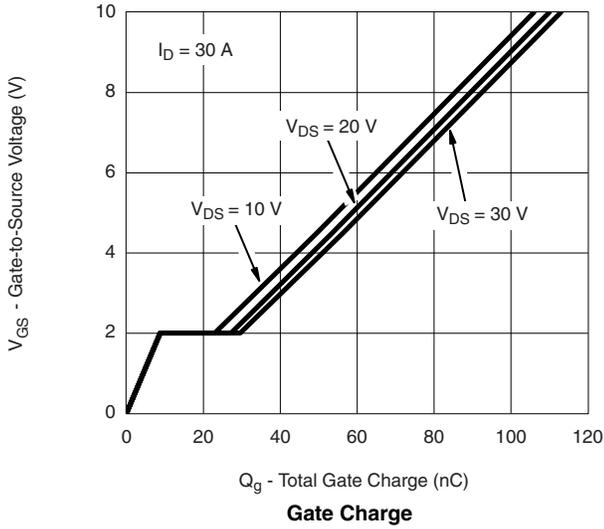


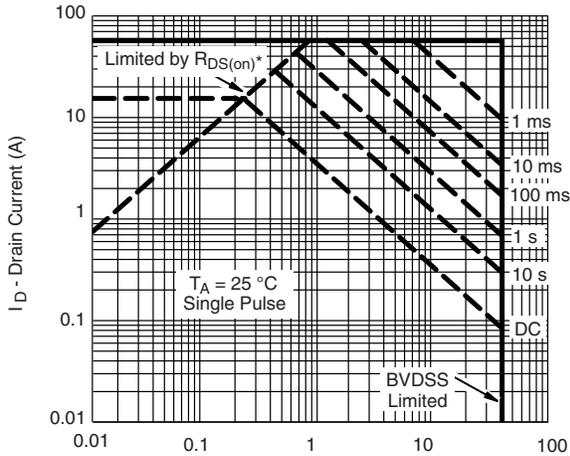
$I_D = 15\text{ A}$   
 $T_C = 125^\circ\text{C}$   
 $T_C = 25^\circ\text{C}$   
**On-Resistance vs. Gate-to-Source Voltage**



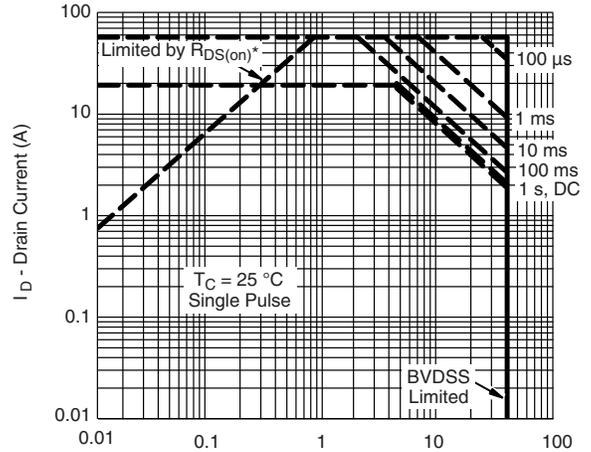
$C_{iss}$   
 $C_{oss}$   
 $C_{rss}$   
**Capacitance**

**TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted

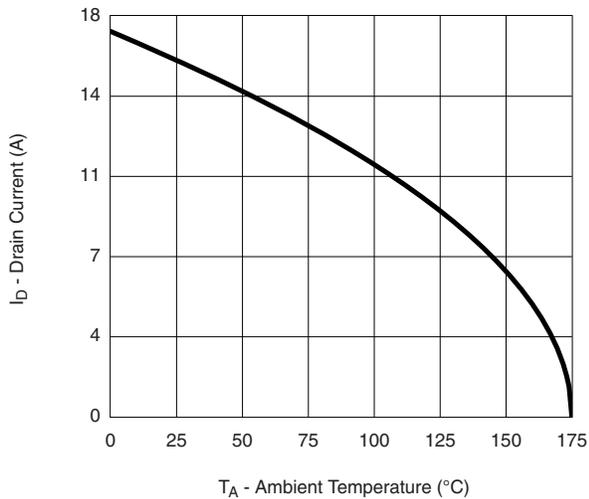


**TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted


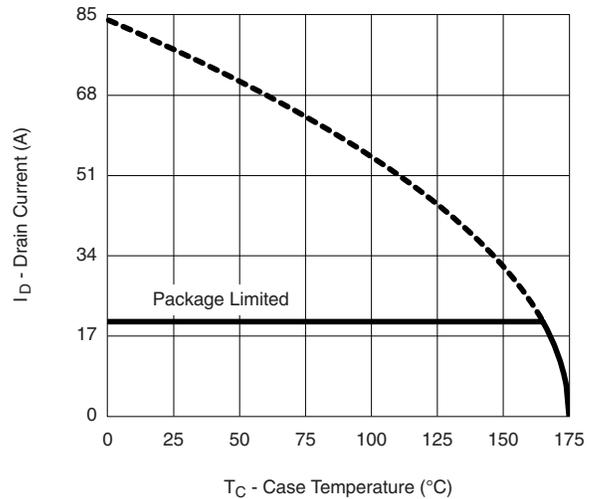
$V_{DS}$  - Drain-to-Source Voltage (V)  
 \*  $V_{GS} >$  minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified  
**Safe Operating Area, Junction-to-Ambient**



$V_{DS}$  - Drain-to-Source Voltage (V)  
 \*  $V_{GS} >$  minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified  
**Safe Operating Area, Junction-to-Case**



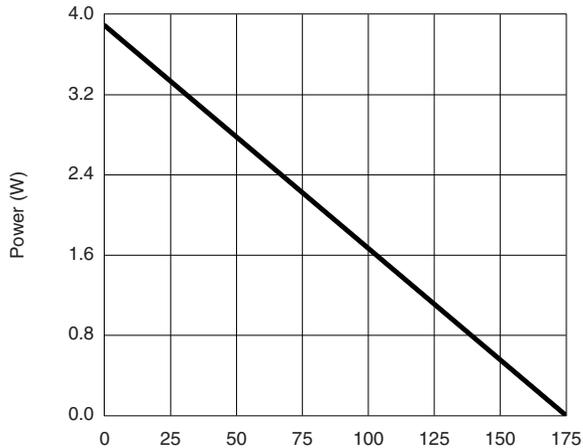
$T_A$  - Ambient Temperature ( $^\circ\text{C}$ )  
**Current Derating\*\*, Junction-to-Ambient**



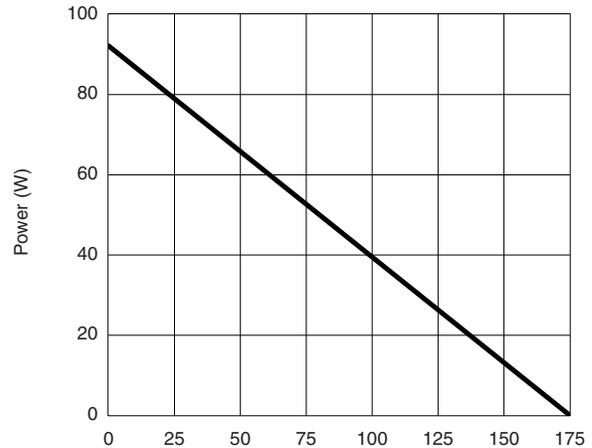
$T_C$  - Case Temperature ( $^\circ\text{C}$ )  
**Current Derating\*\*, Junction-to-Case**

\*\* The power dissipation  $P_D$  is based on  $T_{J(max)} = 175^\circ\text{C}$ , using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

## TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



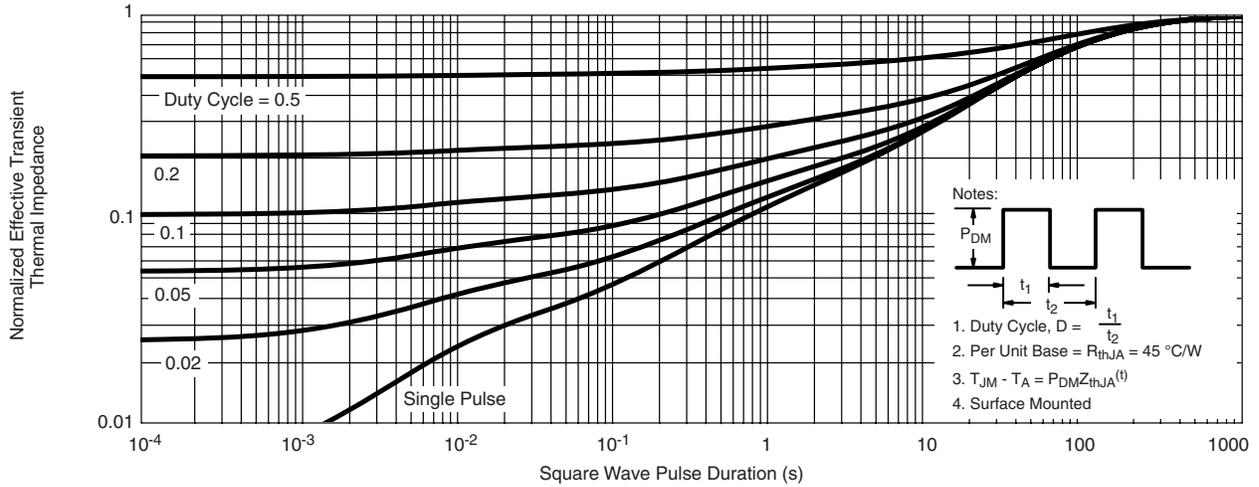
$T_A$  - Ambient Temperature (°C)  
**Power Derating\*, Junction-to-Ambient**



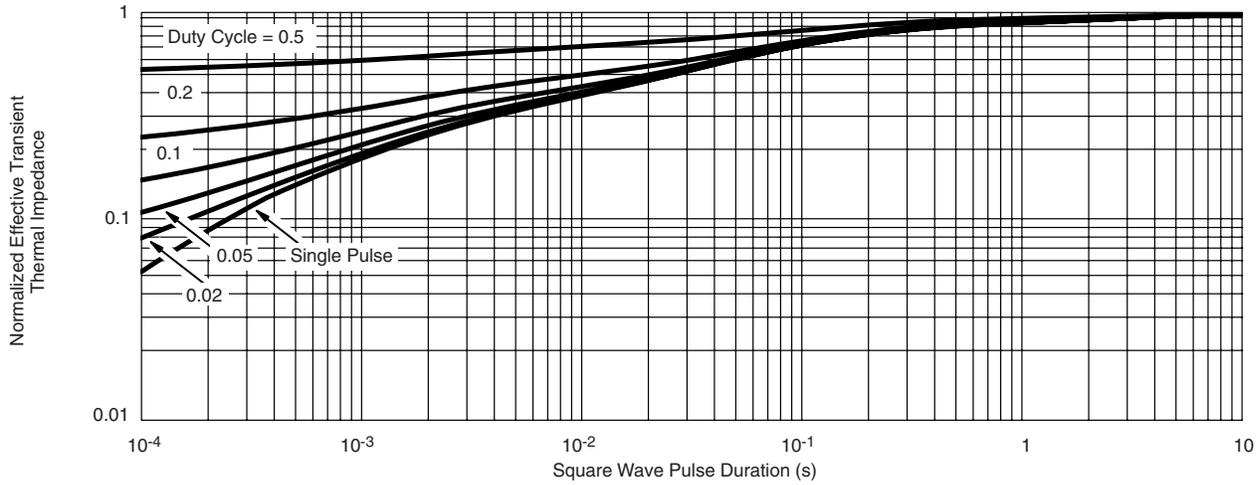
$T_C$  - Case Temperature (°C)  
**Power Derating\*, Junction-to-Case**

\* The power dissipation  $P_D$  is based on  $T_{J(max)} = 175$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

**TYPICAL CHARACTERISTICS** 25 °C, unless otherwise noted



**Normalized Thermal Transient Impedance, Junction-to-Ambient**



**Normalized Thermal Transient Impedance, Junction-to-Case**

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